

Notice of References Cited	Application/Control No. 10/525,598	Applicant(s)/Patent Under Reexamination VAN DE LOGT ET AL.	
	Examiner Christine T. Tu	Art Unit 2117	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,271,700	08-2001	Itaya, Koichi	327/202
*	B	US-6,971,045	11-2005	Deb et al.	714/30
*	C	US-2003/0070128	04-2003	Akasaka et al.	714/726
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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